

MOS FIELD EFFECT TRANSISTOR μ PA1764

SWITCHING DUAL N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The μ PA1764 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- · Dual chip type
- · Low on-state resistance

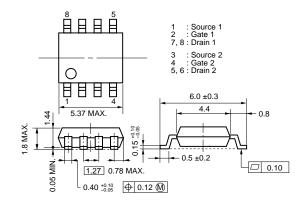
RDS(on)1 = 27 m Ω TYP. (Vgs = 10 V, ID = 3.5 A)

 $R_{DS(on)2} = 32 \text{ m}\Omega \text{ TYP. (Vgs} = 4.5 \text{ V, Ip} = 3.5 \text{ A)}$

 $R_{DS(on)3} = 34 \text{ m}\Omega \text{ TYP.}$ (Vgs = 4.0 V, ID = 3.5 A)

- Low input capacitance
 C_{iss} = 1300 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

PACKAGE DRAWING (Unit: mm)



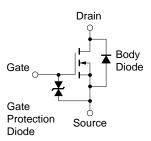
ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|------------|
| μPA1764G | Power SOP8 |

ABSOLUTE MAXIMUM RATINGS (TA = 25°C, All terminals are connected.)

| Drain to Source Voltage (Vgs = 0 V) | VDSS | 60 | V | |
|--|------------------|--------------|----|--|
| Gate to Source Voltage (Vps = 0 V) | Vgss | ±20 | V | |
| Drain Current (DC) (Tc = 25°C) | ID(DC) | ±7 | Α | |
| Drain Current (pulse) Note1 | ID(pulse) | ±28 | Α | |
| Total Power Dissipation (1 unit) Note2 | Рт | 1.7 | W | |
| Total Power Dissipation (2 unit) Note2 | Рт | 2.0 | W | |
| Channel Temperature | Tch | 150 | °C | |
| Storage Temperature | T _{stg} | -55 to + 150 | °C | |
| Single Avalanche Current Note3 | las | 7 | Α | |
| Single Avalanche Energy Note3 | Eas | 98 | mJ | |
| | | | | |

EQUIVALENT CIRCUIT (1/2 Circuit)



- **Notes 1.** PW \leq 10 μ s, Duty cycle \leq 1%
 - **2.** $T_A = 25^{\circ}C$, Mounted on ceramic substrate of 1200 mm² x 2.2 mm
 - 3. Starting T_{ch} = 25°C, V_{DD} = 30 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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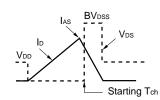


ELECTRICAL CHARACTERISTICS (T_A = 25°C, All terminals are connected.)

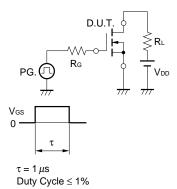
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|--|------|------|------|------|
| Zero Gate Voltage Drain Current | Ipss | Vps = 60 V, Vgs = 0 V | | | 10 | μΑ |
| Gate Leakage Current | lgss | Vgs = ±20 V, Vps = 0 V | | | ±10 | μΑ |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1 mA | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | y fs | V _{DS} = 10 V, I _D = 3.5 A | 5.0 | 9.0 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, ID = 3.5 A | | 27 | 35 | mΩ |
| | RDS(on)2 | Vgs = 4.5 V, ID = 3.5 A | | 32 | 42 | mΩ |
| | RDS(on)3 | Vgs = 4.0 V, ID = 3.5 A | | 34 | 46 | mΩ |
| Input Capacitance | Ciss | V _{DS} = 10 V | | 1300 | | pF |
| Output Capacitance | Coss | Vgs = 0 V | | 230 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1 MHz | | 110 | | pF |
| Turn-on Delay Time | td(on) | V _{DD} = 30 V, I _D = 3.5 A | | 15 | | ns |
| Rise Time | tr | Vgs = 10 V | | 69 | | ns |
| Turn-off Delay Time | td(off) | $R_G = 10 \Omega$ | | 65 | | ns |
| Fall Time | tr | | | 27 | | ns |
| Total Gate Charge | Q _G | V _{DD} = 48 V | | 29 | | nC |
| Gate to Source Charge | Qgs | Vgs = 10 V | | 3.6 | | nC |
| Gate to Drain Charge | Q _{GD} | I _D = 7.0 A | | 7.4 | | nC |
| Body Diode Forward Voltage | VF(S-D) | IF = 7.0 A, VGS = 0 V | | 0.84 | | V |
| Reverse Recovery Time | trr | IF = 7.0 A, VGS = 0 V | | 40 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/μs | | 66 | | nC |

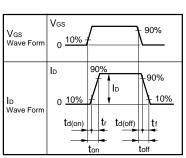
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c|c} \text{D.U.T.} \\ \text{RG} = 25 \ \Omega \\ \text{PG.} \\ \hline \\ \text{VGS} = 20 \rightarrow 0 \ V \end{array} \begin{array}{c} \text{D.U.T.} \\ \\ \text{VDD} \\ \end{array}$

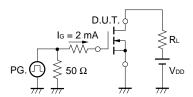


TEST CIRCUIT 2 SWITCHING TIME





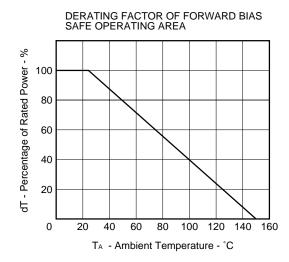
TEST CIRCUIT 3 GATE CHARGE

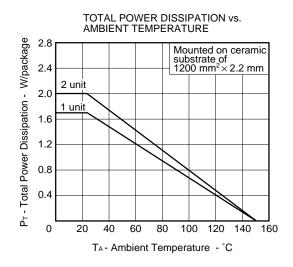


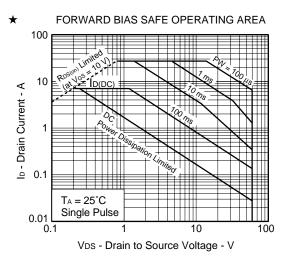
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Data Sheet G14329EJ2V0DS

TYPICAL CHARACTERISTICS (TA = 25°C, All terminals are connected.)

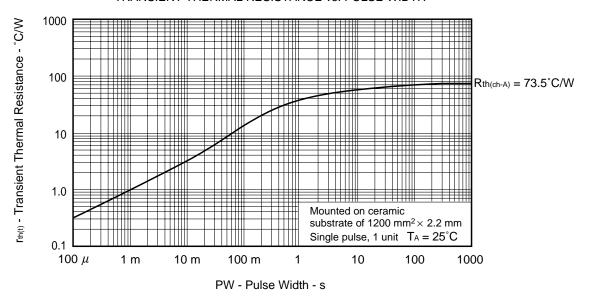




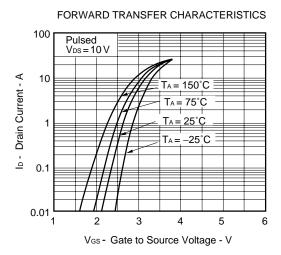


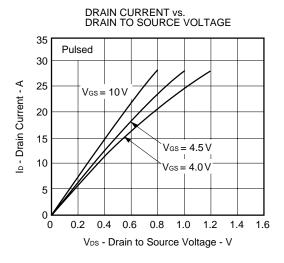
Remark Mounted on ceramic substrate of $1200 \text{ mm}^2 \times 2.2 \text{ mm}$

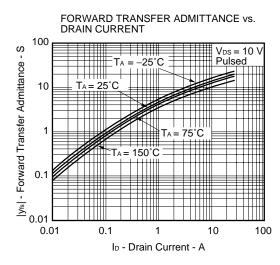
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

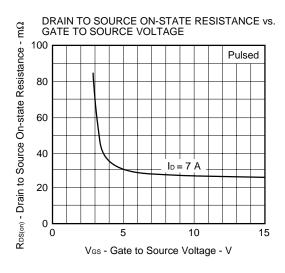


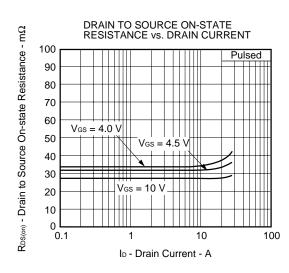
Data Sheet G14329EJ2V0DS

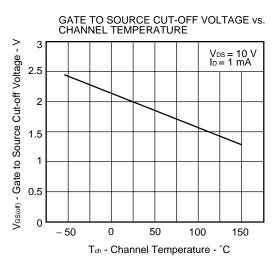


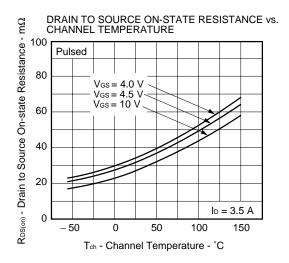


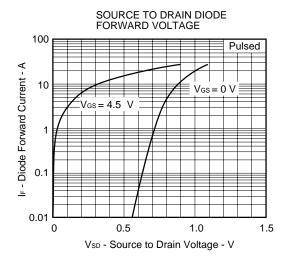


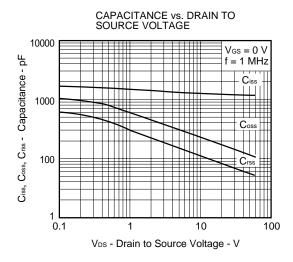


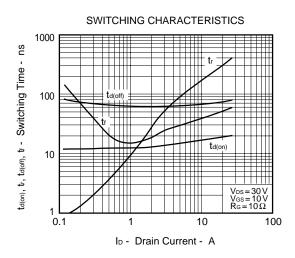


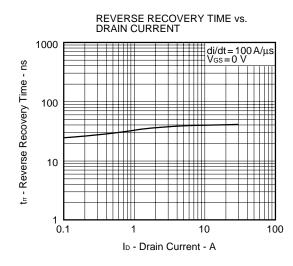


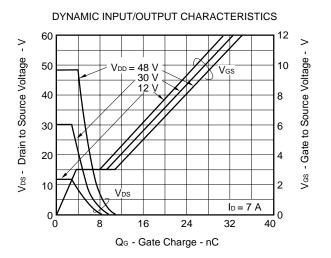












5

100

10

0.1 L_ 10 μ

IAS - Single Avalanche Current - A

SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD AS = 7 A Eq. 98 mg

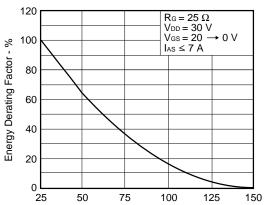
L - Inductive Load - H

100 μ

 $\begin{array}{c|c} R_G = 25~\Omega\\ V_{DD} = 30~V\\ V_{GS} = 20 \longrightarrow 0~V\\ Starting~T_{ch} = 25^{\circ}C \end{array}$

10 m

SINGLE AVALANCHE ENERGY DERATING FACTOR



Starting Tch - Starting Channel Temperature - $^{\circ}$ C

NEC μ PA1764

[MEMO]

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